

<b>Notice of References Cited</b>	Application/Control No. 10/706,366	Applicant(s)/Patent Under Reexamination TSUDA, HIDEAKI	
	Examiner (Nancy) Thanh-Nhan P. Nguyen	Art Unit 2871	Page 1 of 1

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*	B	US-2004/0114087	06-2004	Cho et al.	349/155
*	C	US-6,396,559	05-2002	Kishimoto et al.	349/156
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**NON-PATENT DOCUMENTS**

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